

Notice of References Cited	Application/Control No. 10/812,624		Applicant(s)/Patent Under Reexamination DELACRUZ, CEDRIC G.	
	Examiner BIJENDRA K. SHRESTHA		Art Unit 3691	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,741,969	05-2004	Chen et al.	705/14
*	B	US-6,272,473	08-2001	Sandholm, Tuomas	705/37
*	C	US-6,138,106	10-2000	Walker et al.	705/14
*	D	US-6,285,986	09-2001	Andrews, Christopher C.	705/26
*	E	US-6,012,045	01-2000	Barzilai et al.	705/37
*	F	US-6,047,274	04-2000	Johnson et al.	705/412
*	G	US-6,370,514	04-2002	Messner, Marc A.	705/14
*	H	US-7,016,873	03-2006	Peterson et al.	705/36R
*	I	US-6,594,640	07-2003	Postrel, Richard	705/14
*	J	US-6,240,397	05-2001	Sachs, Arye	705/27
*	K	US-6,330,544	12-2001	Walker et al.	705/14
*	L	US-7,209,889	04-2007	Whitfield, Henry	705/14
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.